

Search Notes

Application/Control No.

10/511,365

Examiner

Hieu P. Nguyen

Applicant(s)/Patent under
Reexamination

TEN DOLLE ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	252	1/4/2006	HN
330	301	1/8/2006	HN
330	311	1/8/2006	HN
330	252-260	5/25/2006	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
US-PGPUB		7/24/2006	HN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
MOTTOLA STEVEN J	1/4/2006	HN
EAST UPDATE SEARCH PLEASE SEE PRINTOUT	7/24/2006	HN